

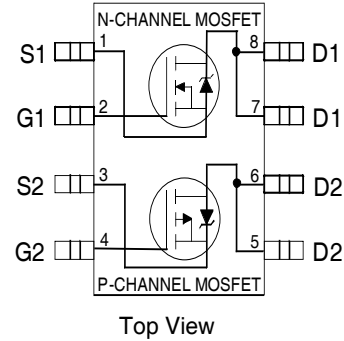
**Features**

N-Ch:

- $V_{DS}(V)=55V$
- $R_{DS(ON)} < 50m\Omega$  ( $V_{GS} = 10V$ )
- $R_{DS(ON)} < 65 m\Omega$  ( $V_{GS} = 4.5V$ )

P-Ch:

- $V_{DS}(V)=-55V$
- $R_{DS(ON)} < 90m\Omega$  ( $V_{GS} = 10V$ )
- $R_{DS(ON)} < 100m\Omega$  ( $V_{GS} = 4.5V$ )
- Generation V Technology
- Ultra Low On-Resistance
- Surface Mount
- Fully Avalanche Rated
- Lead-Free



**Description**

The SOP-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. with these improvements. mutipe devices can be used in an appication with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques.

**Absolute Maximum Ratings**

	Parameter	Max.		Units
		N-Channel	P-Channel	
$V_{DS}$	Drain-Source Voltage	55	-55	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	4.7	-3.4	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	3.8	-2.7	
$I_{DM}$	Pulsed Drain Current ①	38	-27	
$P_D @ T_A = 25^\circ C$	Maximum Power Dissipation ⑤	2.0		W
$P_D @ T_A = 70^\circ C$	Maximum Power Dissipation ⑤	1.3		W
$E_{AS}$	Single Pulse Avalanche Energy ③	72	114	mJ
$I_{AR}$	Avalanche Current	4.7	-3.4	A
$E_{AR}$	Repetitive Avalanche Energy	0.20		mJ
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$		V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	5.0	-5.0	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to + 150		$^\circ C$

**Thermal Resistance**

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ⑤		62.5	$^\circ C/W$

**Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)**

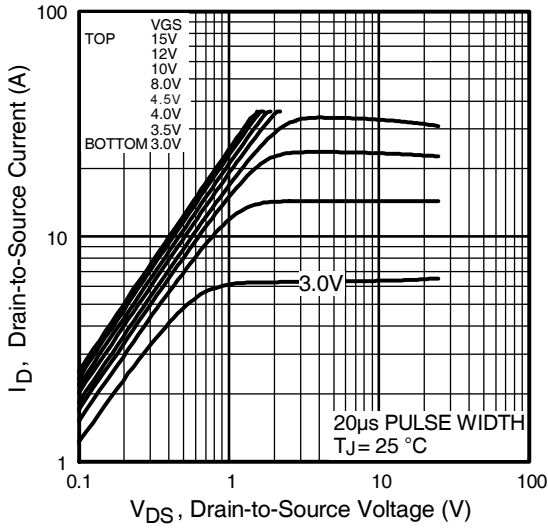
	Parameter		Min.	Typ.	Max.	Units	Conditions	
							N-Ch	P-Ch
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	N-Ch	55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	
		P-Ch	-55				V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	N-Ch	0.059			V/°C	Reference to 25°C, I <sub>D</sub> = 1mA	
		P-Ch	0.054				Reference to 25°C, I <sub>D</sub> = -1mA	
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance	N-Ch	43	50		mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.7A ④	
			56	65			V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.8A ④	
		P-Ch	70	90			V <sub>GS</sub> = -10V, I <sub>D</sub> = -3.4A ④	
			95	100			V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -2.7A ④	
V <sub>GS(th)</sub>	Gate Threshold Voltage	N-Ch	1.0			V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	
		P-Ch	-1.0				V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA	
g <sub>fs</sub>	Forward Transconductance	N-Ch	7.9			S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 4.5A ④	
		P-Ch	3.3				V <sub>DS</sub> = -10V, I <sub>D</sub> = -3.1A ④	
I <sub>DSS</sub>	Drain-to-Source Leakage Current	N-Ch			2.0	μA	V <sub>DS</sub> = 55V, V <sub>GS</sub> = 0V	
							-2.0	V <sub>DS</sub> = -55V, V <sub>GS</sub> = 0V
		P-Ch			25		V <sub>DS</sub> = 55V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C	
					-25		V <sub>DS</sub> = -55V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C	
I <sub>GSS</sub>	Gate-to-Source Forward Leakage	N-P			±100	nA	V <sub>GS</sub> = ±20V	
Q <sub>g</sub>	Total Gate Charge	N-Ch	24	36		nC	N-Channel I <sub>D</sub> = 4.5A, V <sub>DS</sub> = 44V, V <sub>GS</sub> = 10V	
		P-Ch	26	38				
Q <sub>gs</sub>	Gate-to-Source Charge	N-Ch	2.3	3.4			P-Channel I <sub>D</sub> = -3.1A, V <sub>DS</sub> = -44V, V <sub>GS</sub> = -10V	
		P-Ch	3.0	4.5				
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge	N-Ch	7.0	10				
		P-Ch	8.4	13				
t <sub>d(on)</sub>	Turn-On Delay Time	N-Ch	8.3	12		ns	N-Channel V <sub>DD</sub> = 28V, I <sub>D</sub> = 1.0A, R <sub>G</sub> = 6.0Ω, R <sub>D</sub> = 16Ω	
		P-Ch	14	22				
t <sub>r</sub>	Rise Time	N-Ch	10	15			P-Channel V <sub>DD</sub> = -28V, I <sub>D</sub> = -1.0A, R <sub>G</sub> = 6.0Ω, R <sub>D</sub> = 16Ω	
		P-Ch	10	15				
t <sub>d(off)</sub>	Turn-Off Delay Time	N-Ch	32	48				
		P-Ch	43	64				
t <sub>f</sub>	Fall Time	N-Ch	13	20				
		P-Ch	22	32				
C <sub>iss</sub>	Input Capacitance	N-Ch	740			pF	N-Channel V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1.0MHz	
		P-Ch	690					
C <sub>oss</sub>	Output Capacitance	N-Ch	190				P-Channel V <sub>GS</sub> = 0V, V <sub>DS</sub> = -25V, f = 1.0MHz	
		P-Ch	210					
C <sub>riss</sub>	Reverse Transfer Capacitance	N-Ch	71					
		P-Ch	86					

**Source-Drain Ratings and Characteristics**

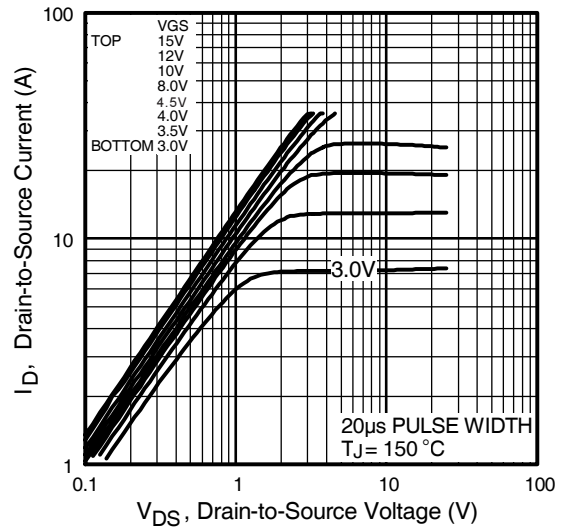
	Parameter		Min.	Typ.	Max.	Units	Conditions	
							N-Ch	P-Ch
I <sub>S</sub>	Continuous Source Current (Body Diode)	N-Ch			2.0	A		
		P-Ch			-2.0			
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	N-Ch			38			
		P-Ch			-27			
V <sub>SD</sub>	Diode Forward Voltage	N-Ch	0.70	1.2		V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 2.0A, V <sub>GS</sub> = 0V ③	
		P-Ch	-0.80	-1.2				T <sub>J</sub> = 25°C, I <sub>S</sub> = -2.0A, V <sub>GS</sub> = 0V ③
t <sub>rr</sub>	Reverse Recovery Time	N-Ch	60	90		ns	N-Channel T <sub>J</sub> = 25°C, I <sub>F</sub> = 2.0A, di/dt = 100A/μs	
		P-Ch	54	80				
Q <sub>rr</sub>	Reverse Recovery Charge	N-Ch	120	170		nC	P-Channel T <sub>J</sub> = 25°C, I <sub>F</sub> = -2.0A, di/dt = 100A/μs ④	
		P-Ch	85	130				

**Notes:**

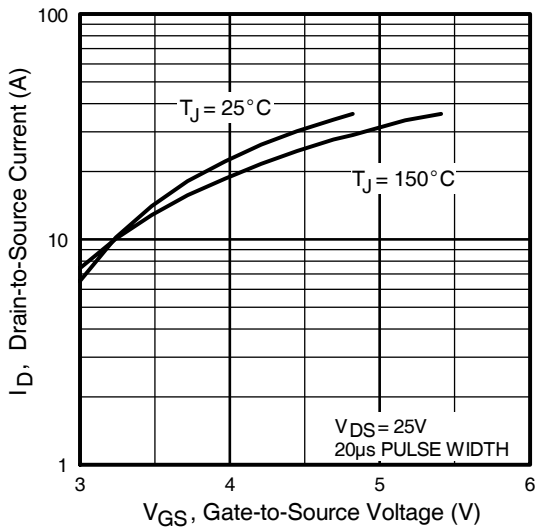
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 22 )
- ② N-Channel I<sub>SD</sub> ≤ 4.7A, di/dt ≤ 220A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C  
P-Channel I<sub>SD</sub> ≤ -3.4A, di/dt ≤ -150A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C
- ③ N-Channel Starting T<sub>J</sub> = 25°C, L = 6.5mH R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 4.7A.  
P-Channel Starting T<sub>J</sub> = 25°C, L = 20mH R<sub>G</sub> = 25Ω, I<sub>AS</sub> = -3.4A.
- ④ Pulse width ≤ 300μs; duty cycle ≤ 2%.
- ⑤ Surface mounted on FR-4 board, t ≤ 10sec.



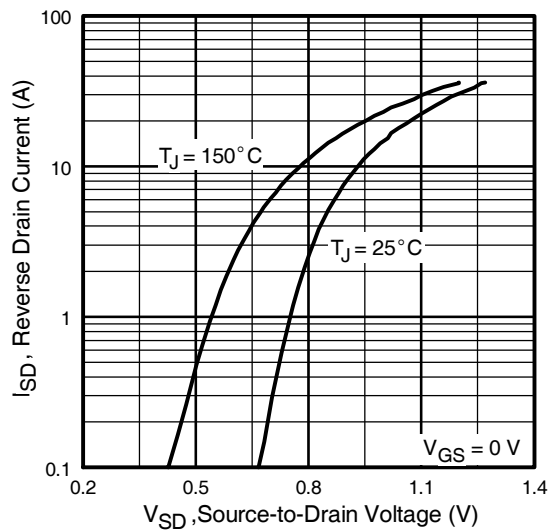
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics

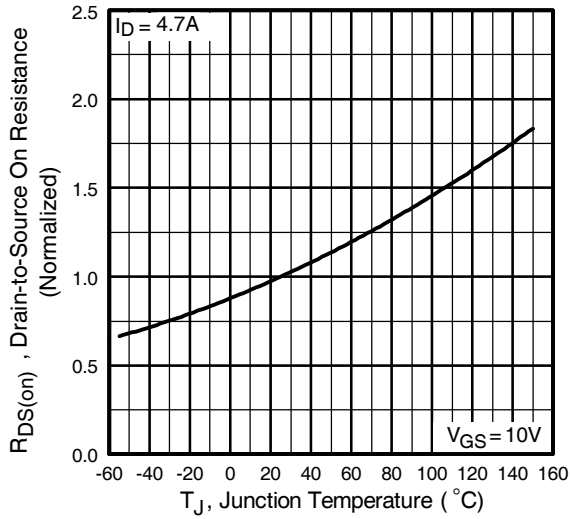


**Fig 3.** Typical Transfer Characteristics

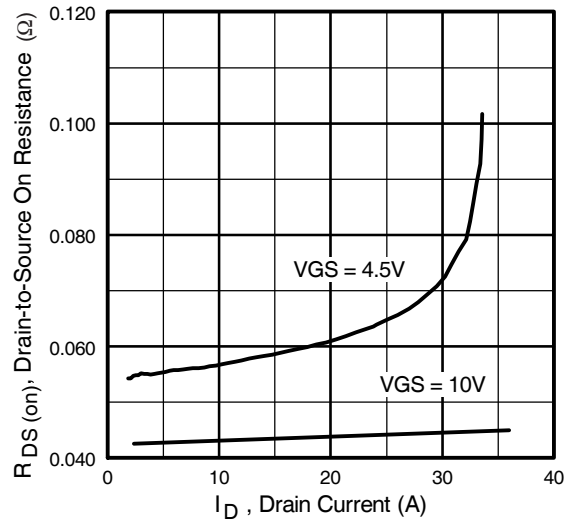


**Fig 4.** Typical Source-Drain Diode Forward Voltage

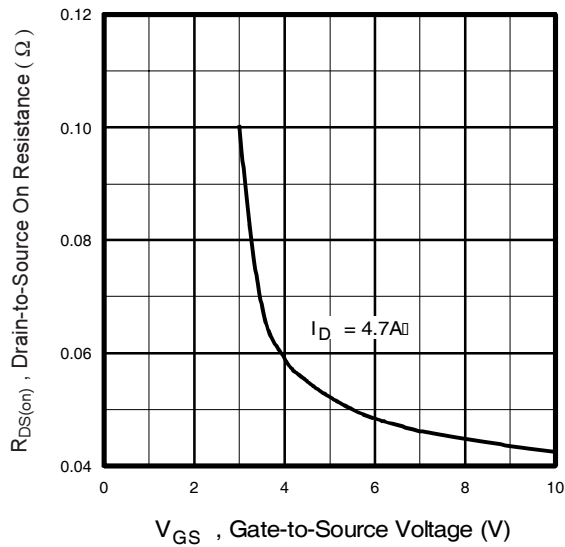
N-Channel



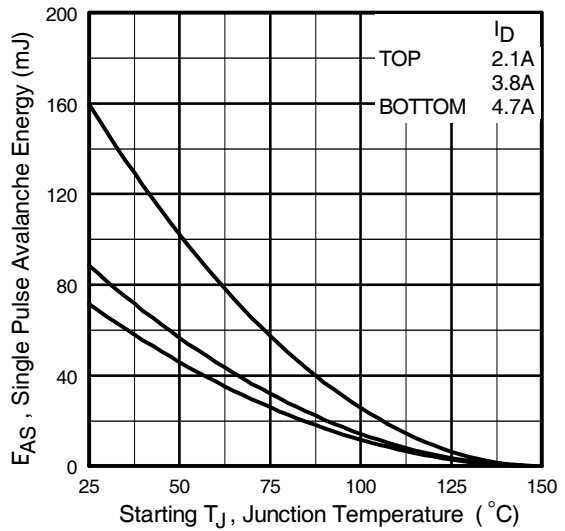
**Fig 5.** Normalized On-Resistance Vs. Temperature



**Fig 6.** Typical On-Resistance Vs. Drain Current

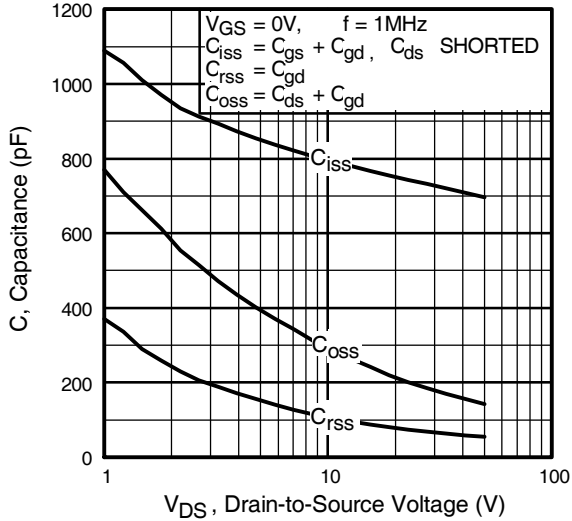


**Fig 7.** Typical On-Resistance Vs. Gate Voltage

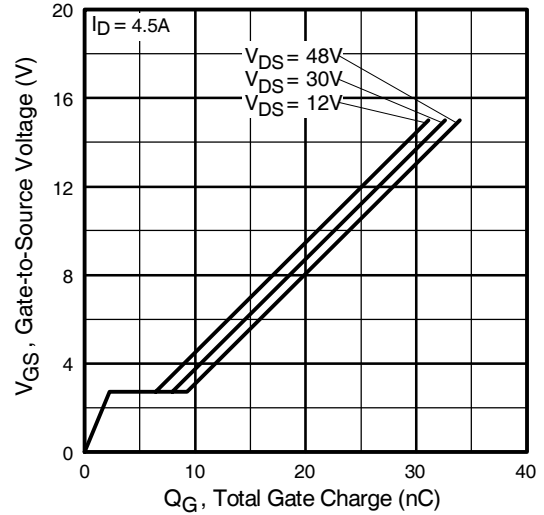


**Fig 8.** Maximum Avalanche Energy Vs. Drain Current

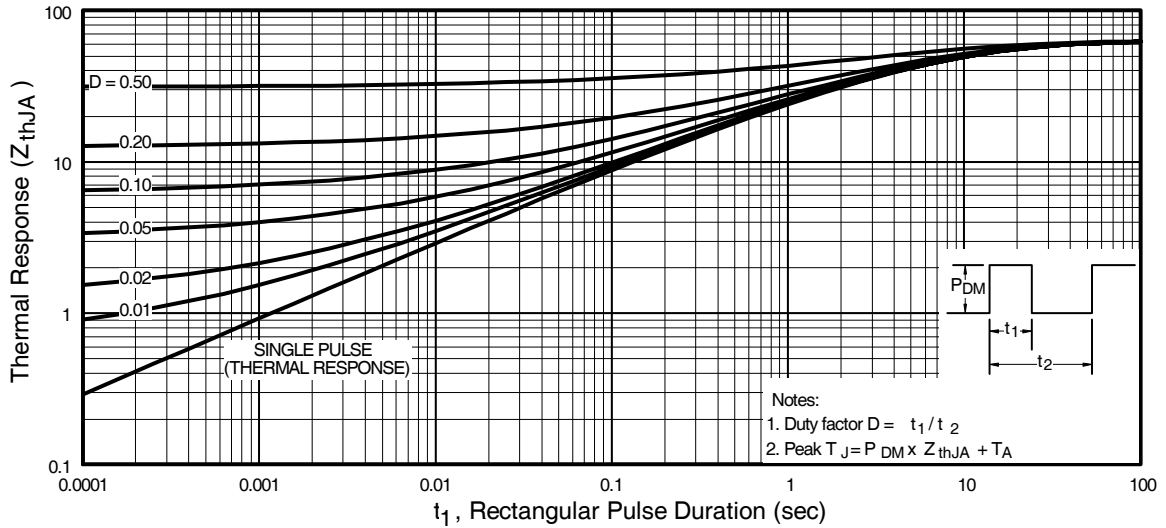
N-Channel



**Fig 9.** Typical Capacitance Vs. Drain-to-Source Voltage

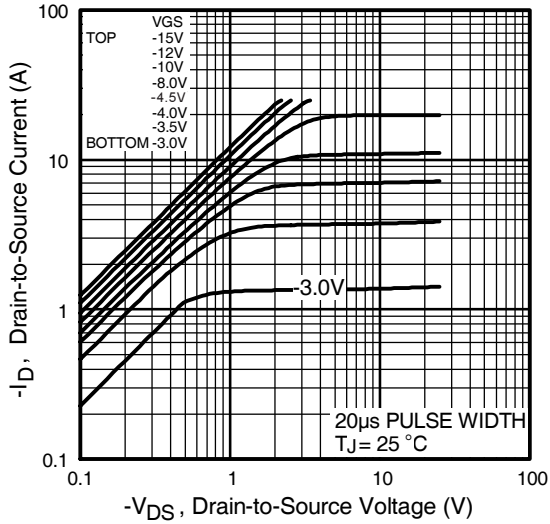


**Fig 10.** Typical Gate Charge Vs. Gate-to-Source Voltage

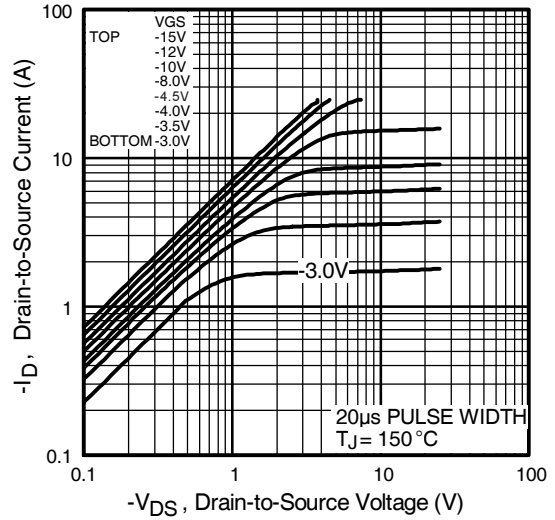


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

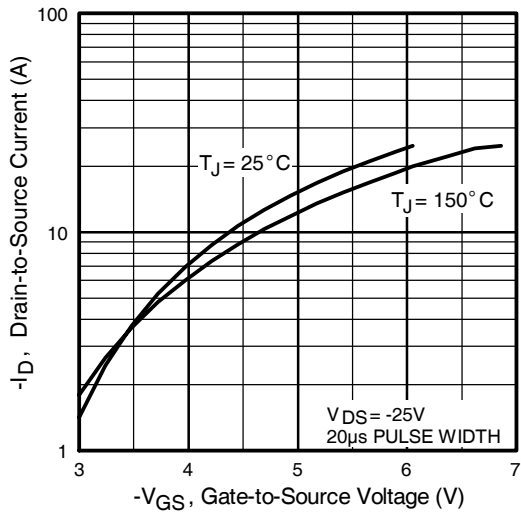
P-Channel



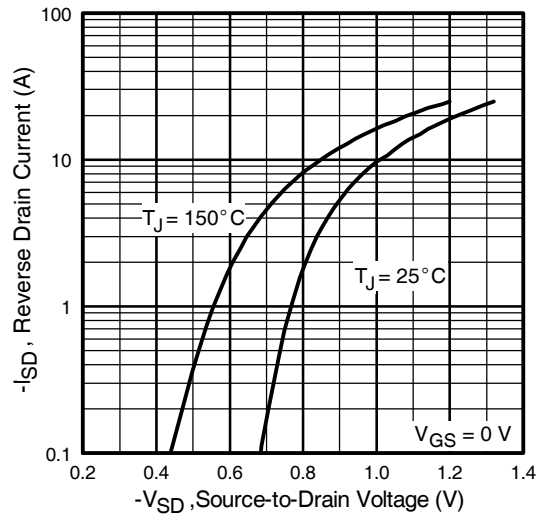
**Fig 12.** Typical Output Characteristics



**Fig 13.** Typical Output Characteristics

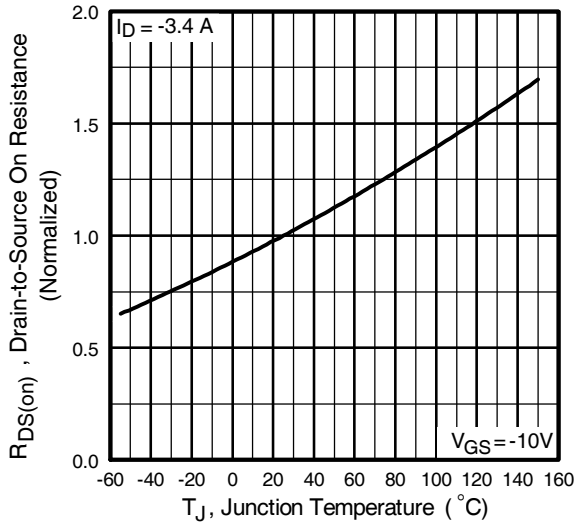


**Fig 14.** Typical Transfer Characteristics

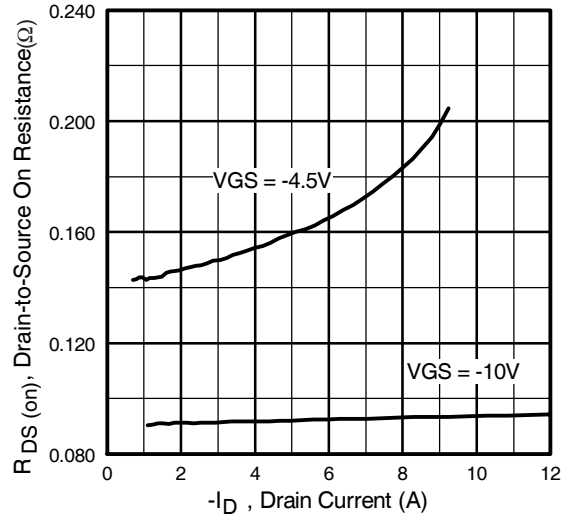


**Fig 15.** Typical Source-Drain Diode Forward Voltage

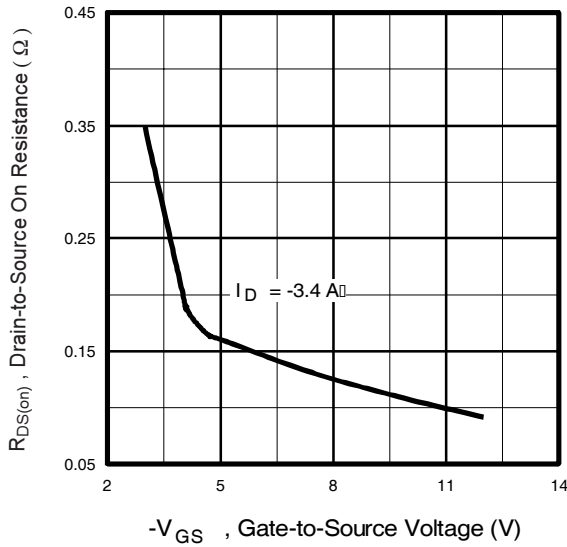
P-Channel



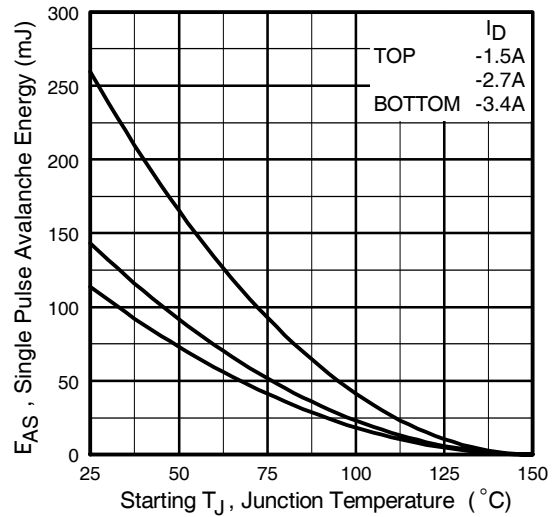
**Fig 16.** Normalized On-Resistance Vs. Temperature



**Fig 17.** Typical On-Resistance Vs. Drain Current

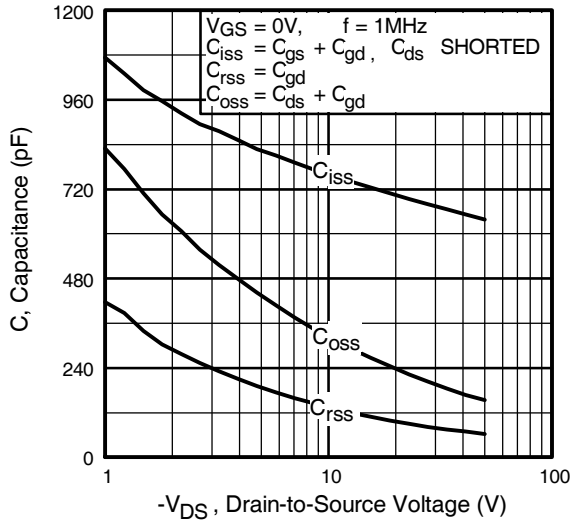


**Fig 18.** Typical On-Resistance Vs. Gate Voltage

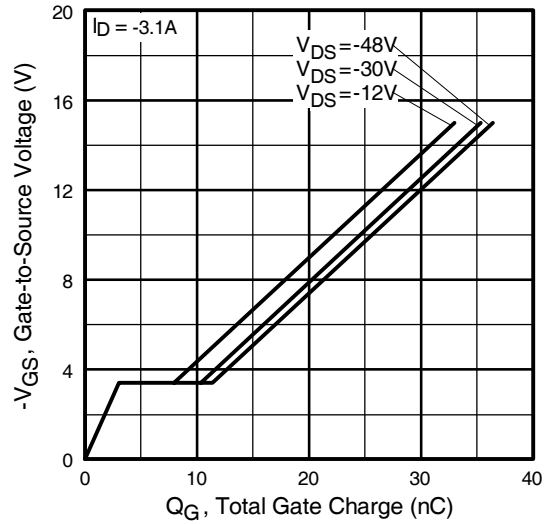


**Fig 19.** Maximum Avalanche Energy Vs. Drain Current

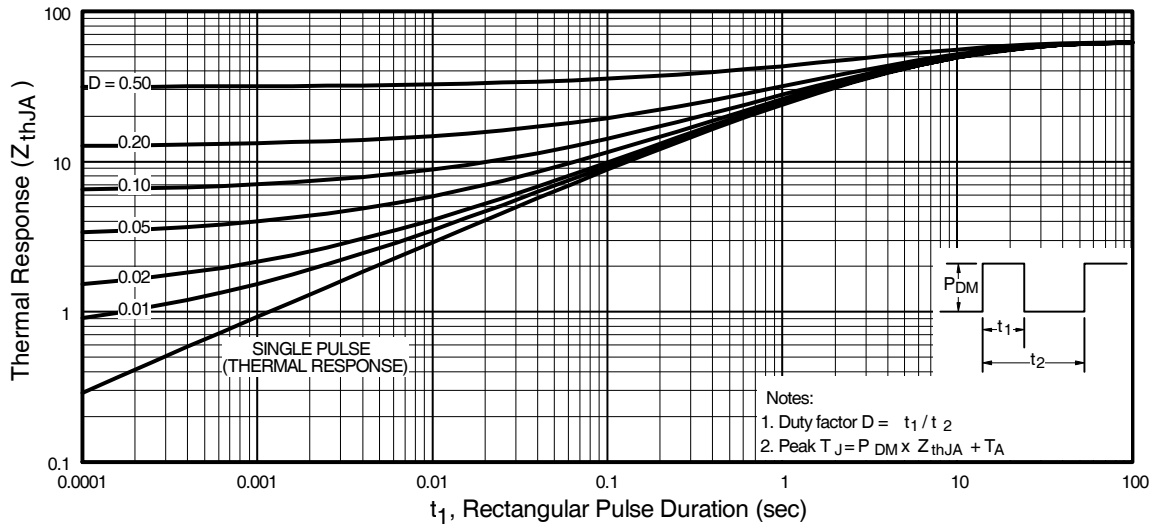
P-Channel



**Fig 20.** Typical Capacitance Vs. Drain-to-Source Voltage



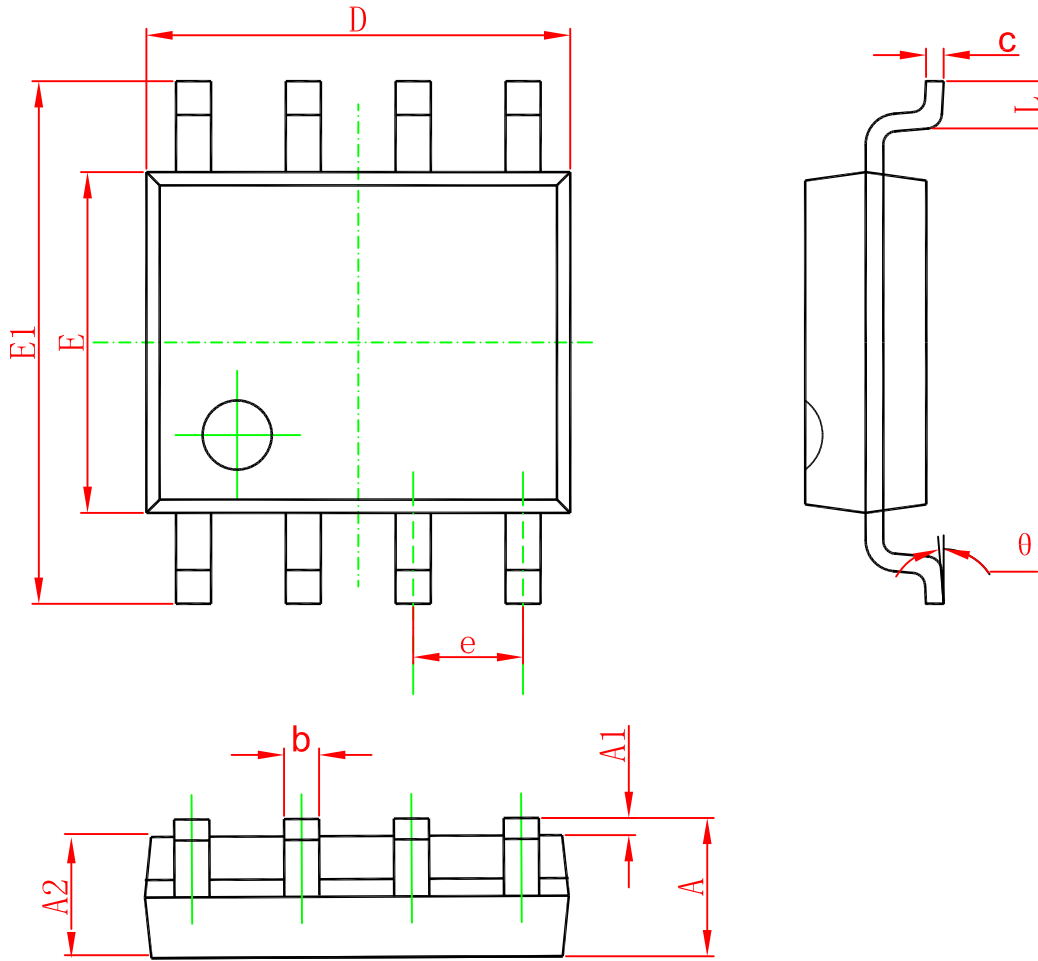
**Fig 21.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 22.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

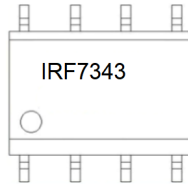


**SOP-8**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
theta	0°	8°	0°	8°

## Marking



## Ordering information

Order code	Package	Baseqty	Deliverymode
IRF7343TR	SOP-8	3000	Tape and reel